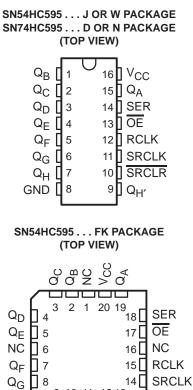
- 8-Bit Serial-In, Parallel-Out Shift
- High-Current 3-State Outputs Can Drive up to 15 LSTTL Loads
- Shift Register Has Direct Clear
- Package Options Include Plastic Small-Outline (D) and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

description

The 'HC595 contain an 8-bit serial-in, parallel-out shift register that feeds an 8-bit D-type storage register. The storage register has parallel 3-state outputs. Separate clocks are provided for both the shift and storage register. The shift register has a direct overriding clear (SRCLR) input, serial (SER) input, and serial outputs for cascading.

Both the shift register clock (RCLK) and storage register clock (SRCLK) are positive-edge triggered. If both clocks are connected together, the shift register is always one clock pulse ahead of the storage register.

The SN54HC595 is characterized for operation over the full military temperature range of -55° C to 125°C. The SN74HC595 is characterized for operation from -40° C to 85°C.



9 10 11

NC - No internal connection

12 13

SRCLI



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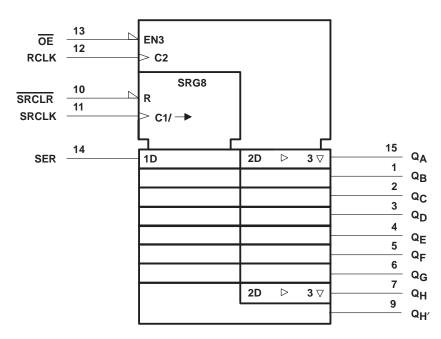
PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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SN54HC595, SN74HC595 **8-BIT SHIFT REGISTERS** WITH 3-STATE OUTPUT REGISTERS SCLS041B – DECEMBER 1982 – REVISED MAY 1997

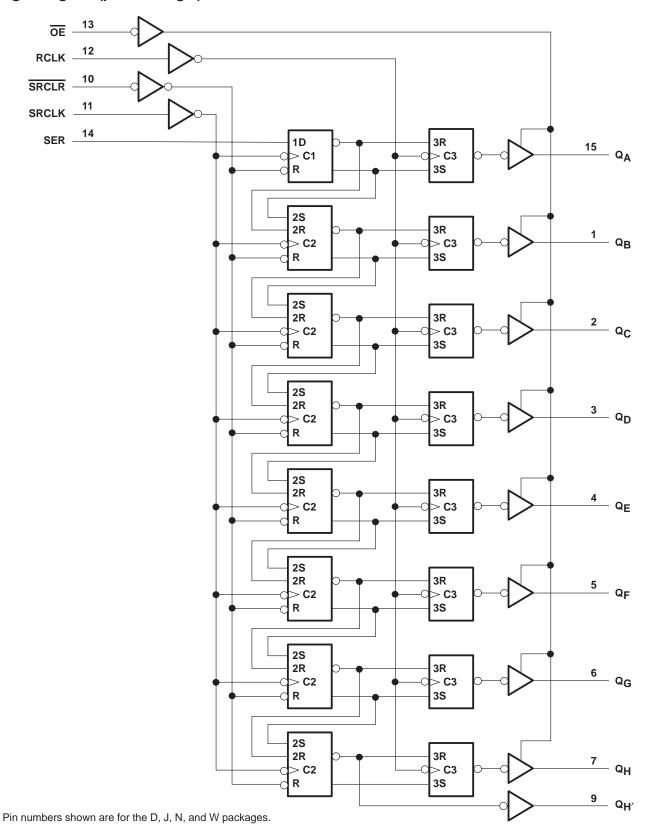
logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, J, N, and W packages.



logic diagram (positive logic)





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absolute maximum ratings over operating free-air temperature range[†]

	A A A N
N package	
Storage temperature range, T _{stg} 65°C to 150°C	С

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.

recommended operating conditions

			SN	154HC59	95	SN74HC595			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage		2	5	6	2	5	6	V
		$V_{CC} = 2 V$	1.5			1.5			
VIH	High-level input voltage	$V_{CC} = 4.5 V$	3.15			3.15			V
		$V_{CC} = 6 V$	4.2			4.2			
		$V_{CC} = 2 V$	0		0.5	0		0.5	
VIL	Low-level input voltage	$V_{CC} = 4.5 V$	0		1.35	0		1.35	V
		$V_{CC} = 6 V$	0		1.8	0		1.8	
VI	Input voltage		0		VCC	0		VCC	V
Vo	Output voltage		0		VCC	0		VCC	V
		$V_{CC} = 2 V$	0		1000	0		1000	
tt‡	Input transition (rise and fall) time	V _{CC} = 4.5 V	0		500	0		500	ns
		$V_{CC} = 6 V$	0		400	0		400	
Тд	Operating free-air temperature		-55		125	-40		85	°C

[‡] If this device is used in the threshold region (from V_{II} max = 0.5 V to V_{IH}min = 1.5 V), there is a potential to go into the wrong state from induced grounding, causing double clocking. Operating with the inputs at tt = 1000 ns and V_{CC} = 2 V does not damage the device; however, functionally, the CLK inputs are not ensured while in the shift, count, or toggle operating modes.



SN54HC595, SN74HC595 8-BIT SHIFT REGISTERS WITH 3-STATE OUTPUT REGISTERS SCLS041B – DECEMBER 1982 – REVISED MAY 1997

electrical	characteristics	over	recommended	operating	free-air	temperature	range	(unless
otherwise	noted)					-	•	

PARAMETER	TEST CONDITIONS		V	Т	A = 25°C	;	SN54F	IC595	SN74H	C595	UNIT
PARAMETER			Vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
			2 V	1.9	1.998		1.9		1.9		
		I _{OH} = -20 μA	4.5 V	4.4	4.499		4.4		4.4		
			6 V	5.9	5.999		5.9		5.9		
VOH	$V_I = V_{IH} \text{ or } V_{IL}$	$Q_{H'}, I_{OH} = -4 \text{ mA}$	4.5 V	3.98	4.3		3.7		3.84		V
		$Q_A - Q_H$, $I_{OH} = -6 \text{ mA}$	4.5 V	3.98	4.3		3.7		3.84		
		Q _{H'} , I _{OH} = -5.2 mA	6 V	5.48	5.8		5.2		5.34		
		$Q_A - Q_H$, $I_{OH} = -7.8$ mA	0.0	5.48	5.8		5.2		5.34		
	VI = VIH or VIL		2 V		0.002	0.1		0.1		0.1	
		I _{OL} = 20 μA	4.5 V		0.001	0.1		0.1		0.1	
			6 V		0.001	0.1		0.1		0.1	
VOL		$Q_{H'}$, $I_{OL} = 4 \text{ mA}$	4.5 V		0.17	0.26		0.4		0.33	V
		$Q_A - Q_H$, $I_{OL} = 6 \text{ mA}$	4.5 V		0.17	0.26		0.4		0.33	
		Q _{H'} , I _{OL} = 5.2 mA	6 V		0.15	0.26		0.4		0.33	
		$Q_A - Q_H$, $I_{OL} = 7.8 \text{ mA}$	0.		0.15	0.26		0.4		0.33	
lı lı	$V_I = V_{CC} \text{ or } 0$		6 V		±0.1	±100		±1000		±1000	nA
loz	AO = ACC or 0		6 V		±0.01	±0.5		±10		±5	μΑ
Icc	$V_I = V_{CC} \text{ or } 0,$	IO = 0	6 V			8		160		80	μΑ
Ci			2 V to 6 V		3	10		10		10	pF



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timing requirements over recommended operating free-air temperature range (unless otherwise noted)

			N	T _A =	25°C	SN54F	IC595	SN74F	IC595	UNIT
			Vcc	MIN	MAX	MIN	MAX	MIN	MAX	
			2 V	0	6	0	4.2	0	5	
fclock	Clock frequency		4.5 V	0	31	0	21	0	25	MHz
			6 V	0	36	0	25	0	29	
			2 V	80		120		100		
		SRCLK or RCLK high or low	4.5 V	16		24		20		
	Pulse duration		6 V	14		20		17		-
t _w	Fulse duration		2 V	80		120		100		ns
		SRCLR low	4.5 V	16		24		20		
			6 V	14		20		17		
		SER before SRCLK [↑]	2 V	100		150		125		
			4.5 V	20		30		25		
			6 V	17		25		21		
			2 V	75		113		94		
		SRCLK↑ before RCLK↑†	4.5 V	15		23		19		
-		6 V	13		19		16		-	
lsu	Setup time		2 V	50		75		65		ns
		SRCLR low before RCLK [↑]	4.5 V	10		15		13		
			6 V	9		13		11		
			2 V	50		75		60		
		SRCLR high (inactive) before SRCLK	4.5 V	10		15		12		
		6 V	9		13		11			
			2 V	0		0		0		
t _h	Hold time, SER af	ter SRCLK↑	4.5 V	0		0		0		ns
			6 V	0		0		0		

[†] This setup time ensures the output register sees stable data from the shift-register outputs. The clocks may be tied together, in which case the output register is one clock pulse behind the shift register.



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switching characteristics over recommended operating free-air temperature range, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	N	Т	₄ = 25°C	;	SN54F	IC595	SN74H	IC595	UNIT			
PARAMETER	(INPUT)	(OUTPUT)	Vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT			
			2 V	6	26		4.2		5					
fmax			4.5 V	31	38		21		25		MHz			
			6 V	36	42		25		29					
			2 V		50	160		240		200				
	SRCLK	Q _{H′}	4.5 V		17	32		48		40				
÷.			6 V		14	27		41		34	ns			
^t pd			2 V		50	150		225		187	115			
	RCLK	Q _A –Q _H	4.5 V		17	30		45		37				
			6 V		14	26		38		32				
	SRCLR				2 V		51	175		261		219		
^t PHL		IR Q _H ′	Q _H ′	4.5 V		18	35		52		44	ns		
			6 V		15	30		44		37				
	ŌĒ					2 V		40	150		225		187	
ten		Q _A –Q _H	Q _A –Q _H	4.5 V		15	30		45		37	ns		
			6 V		13	26		38		32				
			2 V		42	200		300		250				
^t dis	OE	Q _A –Q _H	4.5 V		23	40		60		50	ns			
			6 V		20	34		51		43				
			2 V		28	60		90		75				
		Q _A –Q _H	4.5 V		8	12		18		15				
+.			6 V		6	10		15		13	ns			
tt			2 V		28	75		110		95	5			
		Q _{H′}	4.5 V		8	15		22		19				
			6 V		6	13		19		16				

switching characteristics over recommended operating free-air temperature range, $C_L = 150 \text{ pF}$ (unless otherwise noted) (see Figure 1)

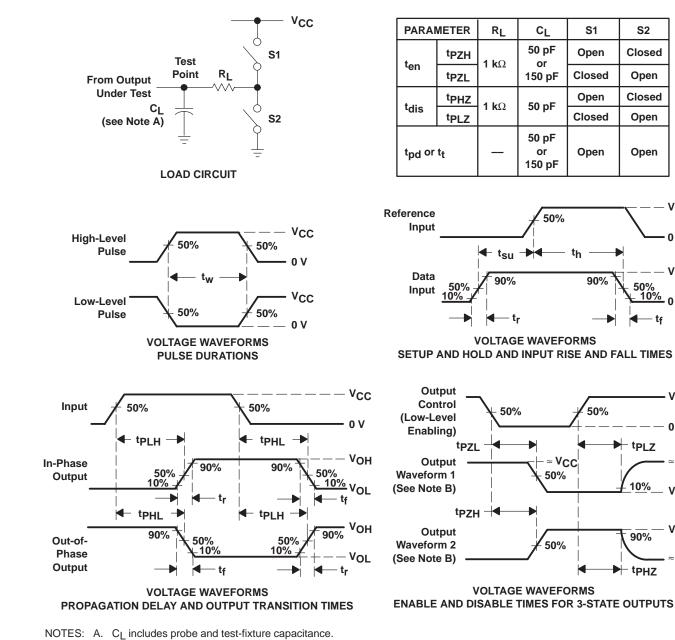
PARAMETER	FROM	то	Vee	Тį	ς = 25°C	;	SN54H	IC595	SN74H	C595	UNIT								
FARAMETER	(INPUT)	(OUTPUT)	(OUTPUT)	Vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT							
			2 V		60	200		300		250									
^t pd	RCLK	Q _A –Q _H	4.5 V		22	40		60		50	ns								
											6 V		19	34		51		43	
	OE		2 V		70	200		298		250									
t _{en}		Q _A –Q _H	4.5 V		23	40		60		50	ns								
			6 V		19	34		51		43									
	Q _A –Q _H	2 V		45	210		315		265										
tt		Q _A –Q _H	Q _A –Q _H	4.5 V		17	42		63		53	ns							
			6 V		13	36		53		45									

operating characteristics, T_A = 25°C

	PARAMETER	TEST CONDITIONS	TYP	UNIT
C _{pd}	Power dissipation capacitance	No load	400	pF



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PARAMETER MEASUREMENT INFORMATION

S2

Closed

Open

Closed

Open

Open

90%

50%

Vcc

0 V

VCC

n v

Vcc

0 V

≈ VCC

VOL

۷он

≈ 0 V

^tPLZ

10%

90%

► tPHZ

10%

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control. C. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following
- characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , t_r = 6 ns, t_f = 6 ns.
- D. For clock inputs, fmax is measured when the input duty cycle is 50%.
- E. The outputs are measured one at a time with one input transition per measurement.
- F. tpLZ and tpHZ are the same as tdis.
- G. tpzL and tpzH are the same as ten.
- H. tPLH and tPHL are the same as tpd.





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